

# FDMS3626S PowerTrench<sup>®</sup> Power Stage 25V Asymmetric Dual N-Channel MOSFET

#### Features

Q1: N-Channel

- Max  $r_{DS(on)}$  = 5.0 m $\Omega$  at V<sub>GS</sub> = 10 V, I<sub>D</sub> = 17.5 A
- Max  $r_{DS(on)} = 5.7 \text{ m}\Omega$  at  $V_{GS} = 4.5 \text{ V}$ ,  $I_D = 16 \text{ A}$

Q2: N-Channel

- Max  $r_{DS(on)}$  = 2.6 m $\Omega$  at V<sub>GS</sub> = 10 V, I<sub>D</sub> = 25 A
- Max r<sub>DS(on)</sub> = 3.2 mΩ at V<sub>GS</sub> = 4.5 V, I<sub>D</sub> = 22 A
- Low inductance packaging shortens rise/fall times, resulting in lower switching losses
- MOSFET integration enables optimum layout for lower circuit inductance and reduced switch node ringing
- RoHS Compliant

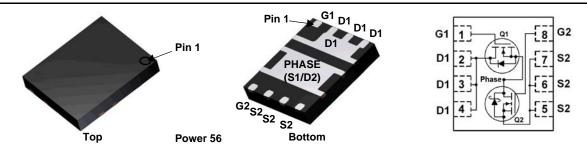


# **General Description**

This device includes two specialized N-Channel MOSFETs in a dual PQFN package. The switch node has been internally connected to enable easy placement and routing of synchronous buck converters. The control MOSFET (Q1) and synchronous SyncFET (Q2) have been designed to provide optimal power efficiency.

## **Applications**

- Computing
- Communications
- General Purpose Point of Load
- Notebook VCORE



## MOSFET Maximum Ratings TA = 25 °C unless otherwise noted

Symbol	Parameter			Q2	Units
V <sub>DS</sub>	Drain to Source Voltage		25	25	V
V <sub>GS</sub>	Gate to Source Voltage	(Note 4)	±12	±12	V
	Drain Current -Continuous (Package limited)	T <sub>C</sub> = 25 °C	30	55	
I <sub>D</sub>	-Continuous	T <sub>A</sub> = 25 °C	17.5 <sup>1a</sup>	25 <sup>1b</sup>	Α
	-Pulsed		70	100	
E <sub>AS</sub>	Single Pulse Avalanche Energy	(Note 3)	29	45 mJ	
P <sub>D</sub>	Power Dissipation for Single Operation	T <sub>A</sub> = 25 °C 2.2 <sup>1a</sup>		2.5 <sup>1b</sup>	W
	Power Dissipation for Single Operation	T <sub>A</sub> = 25 °C	1.0 <sup>1c</sup>	1.0 <sup>1d</sup>	vv
T <sub>J</sub> , T <sub>STG</sub>	Operating and Storage Junction Temperature Range			+150	°C

### **Thermal Characteristics**

$R_{ hetaJA}$	Thermal Resistance, Junction to Ambient	57 <sup>1a</sup>	50 <sup>1b</sup>	
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	125 <sup>1c</sup>	120 <sup>1d</sup>	°C/W
$R_{ ext{ heta}JC}$	Thermal Resistance, Junction to Case	3.0	3.0	

### Package Marking and Ordering Information

Device Marking	Device	Package	Reel Size	Tape Width	Quantity
08OD 10OD	FDMS3626S	Power 56	13 "	12 mm	3000 units

©2011 Fairchild Semiconductor Corporation

FDMS3626S Rev.C2

December 2011

н
ž
ร
Se
62
S
Τ
õ
Se €
Ť
en.
S
2
PC
Ĕ
ē
Ś
ita
ge

Symbol	Parameter	Test Conditions	Туре	Min	Тур	Max	Units
Off Chara	octeristics						
BV <sub>DSS</sub>	Drain to Source Breakdown Voltage	$I_D = 250 \ \mu A, \ V_{GS} = 0 \ V$ $I_D = 1 \ m A, \ V_{GS} = 0 \ V$	Q1 Q2	25 25			V
$\frac{\Delta BV_{DSS}}{\Delta T_J}$	Breakdown Voltage Temperature Coefficient	$I_D = 250 \ \mu$ A, referenced to 25 °C $I_D = 10 \ \text{mA}$ , referenced to 25 °C	Q1 Q2		12 25		mV/°C
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	V <sub>DS</sub> = 20 V, V <sub>GS</sub> = 0 V	Q1 Q2			1 500	μΑ μΑ
I <sub>GSS</sub>	Gate to Source Leakage Current	$V_{GS}$ = 12 V/-8 V, $V_{DS}$ = 0 V	Q1 Q2			±100 ±100	nA nA
On Chara	cteristics						
V <sub>GS(th)</sub>	Gate to Source Threshold Voltage	$V_{GS} = V_{DS}, I_D = 250 \ \mu A$ $V_{GS} = V_{DS}, I_D = 1 \ m A$	Q1 Q2	0.8 1.1	1.2 1.4	2.0 2.2	V
$\frac{\Delta V_{GS(th)}}{\Delta T_J}$	Gate to Source Threshold Voltage Temperature Coefficient	$I_D = 250 \ \mu$ A, referenced to 25 °C $I_D = 10 \ m$ A, referenced to 25 °C	Q1 Q2		-4 -3		mV/°C
r <sub>DS(on)</sub>	Drain to Source On Resistance		Q1		3.8 4.4 5.4	5.0 5.7 7.0	mΩ
'DS(on)			Q2		2.1 2.6 2.9	2.6 3.2 3.8	
9fs	Forward Transconductance	$V_{DS} = 5 V, I_D = 17.5 A$ $V_{DS} = 5 V, I_D = 25 A$	Q1 Q2		100 227		S
Dynamic	Characteristics						
C <sub>iss</sub>	Input Capacitance	Q1: V <sub>DS</sub> = 13 V, V <sub>GS</sub> = 0 V, f = 1 MHZ	Q1 Q2		1570 2545		pF
C <sub>oss</sub>	Output Capacitance	Q2:	Q1 Q2		448 716		pF
C <sub>rss</sub>	Reverse Transfer Capacitance	V <sub>DS</sub> = 13 V, V <sub>GS</sub> = 0 V, f = 1 MHZ	Q1 Q2		61 103		pF
R <sub>g</sub>	Gate Resistance		Q1 Q2		0.4 0.9		Ω
Switching	g Characteristics						
t <sub>d(on)</sub>	Turn-On Delay Time	_	Q1 Q2		7 8		ns
t <sub>r</sub>	Rise Time	_Q1: V <sub>DD</sub> = 13 V, I <sub>D</sub> = 17.5 A, R <sub>GEN</sub> = 6 Ω	Q1 Q2		2 4		ns
t <sub>d(off)</sub>	Turn-Off Delay Time	Q2: V <sub>DD</sub> = 13 V, I <sub>D</sub> = 25 A, R <sub>GEN</sub> = 6 Ω	Q1 Q2		23 31		ns
t <sub>f</sub>	Fall Time		Q1 Q2		2 3		ns
Qg	Total Gate Charge	$V_{GS} = 0$ V to 10 V Q1	Q1 Q2		26 41		nC
Qg	Total Gate Charge	$V_{GS} = 0 V \text{ to } 4.5 V$ $V_{DD} = 13 V,$ $V_{D} = 17.5 A$	Q1 Q2		12 19		nC
Q <sub>gs</sub>	Gate to Source Gate Charge	Q2 V <sub>DD</sub> = 13 V,	Q1 Q2		3.3 4.9		nC
Q <sub>gd</sub>	Gate to Drain "Miller" Charge	$I_{\rm D} = 25 \text{ A}$	Q1 Q2		2.7 4.3		nC

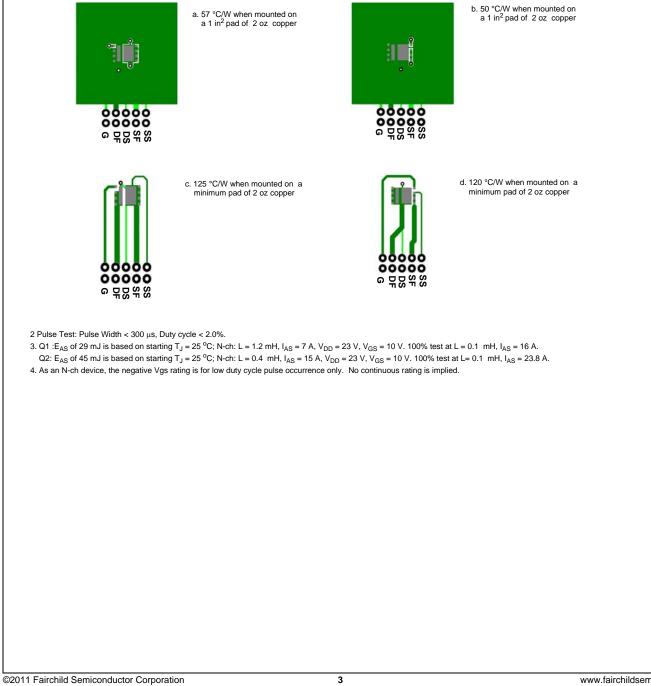
**Electrical Characteristics**  $T_J = 25 \text{ °C}$  unless otherwise noted

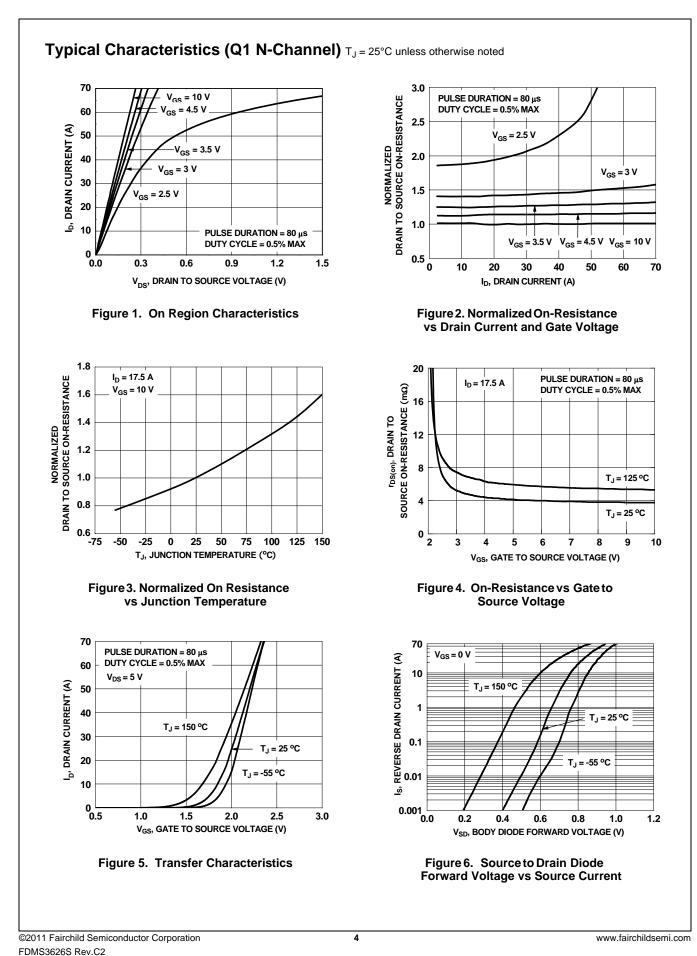
©2011 Fairchild Semiconductor Corporation FDMS3626S Rev.C2

FDMS3626S
3 PowerTrench <sup>®</sup>
Power Stage

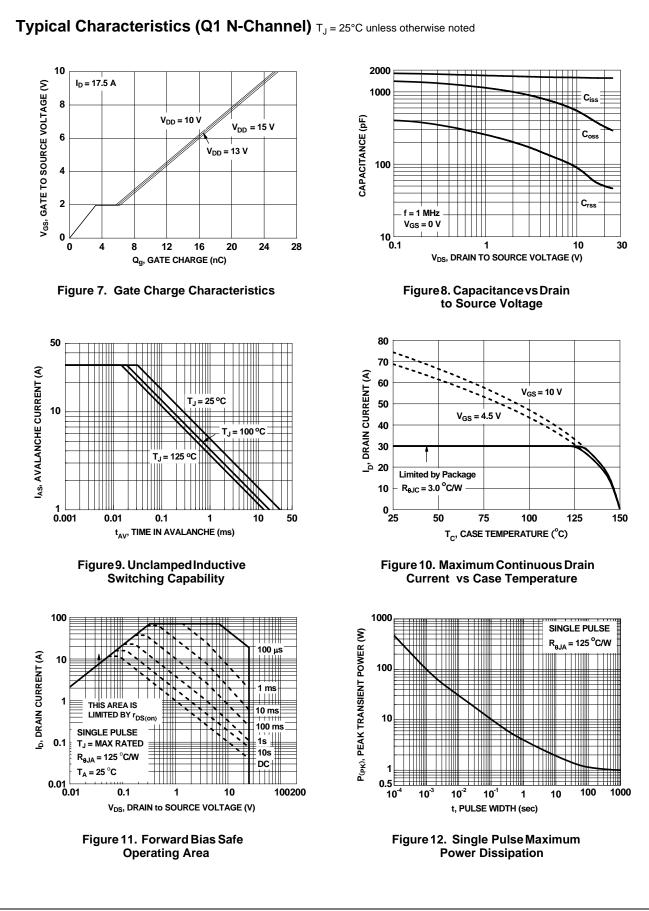
Symbol	Parameter	Test Conditions		Туре	Min	Тур	Max	Units
Drain-Sou	urce Diode Characteristics							
V	Source to Drain Diado Forward Valtage	$V_{GS} = 0 V, I_S = 17.5 A$ (No	ote 2)	Q1		0.8	1.2	V
V <sub>SD</sub> Source to Drain Diode Forward	Source to Drain Diode Forward Voltage	$V_{GS} = 0 V, I_S = 25 A$ (No	ote 2)	Q2		0.8	1.2	v
t <sub>rr</sub> Reverse Recovery		Q1		Q1		23		
	Reverse Recovery Time	I <sub>F</sub> = 17.5 A, di/dt = 100 A/μs		Q2		23		ns
0	Devere Decevery Channel	Q2	F	Q1		9		- 0
Q <sub>rr</sub> Reverse Recovery Charge		I <sub>F</sub> = 25 A, di/dt = 300 A/μs		Q2		22		nC

1.R<sub>0JA</sub> is determined with the device mounted on a 1 in<sup>2</sup> pad 2 oz copper pad on a 1.5 x 1.5 in. board of FR-4 material. R<sub>0JC</sub> is guaranteed by design while R<sub>0CA</sub> is determined by the user's board design.



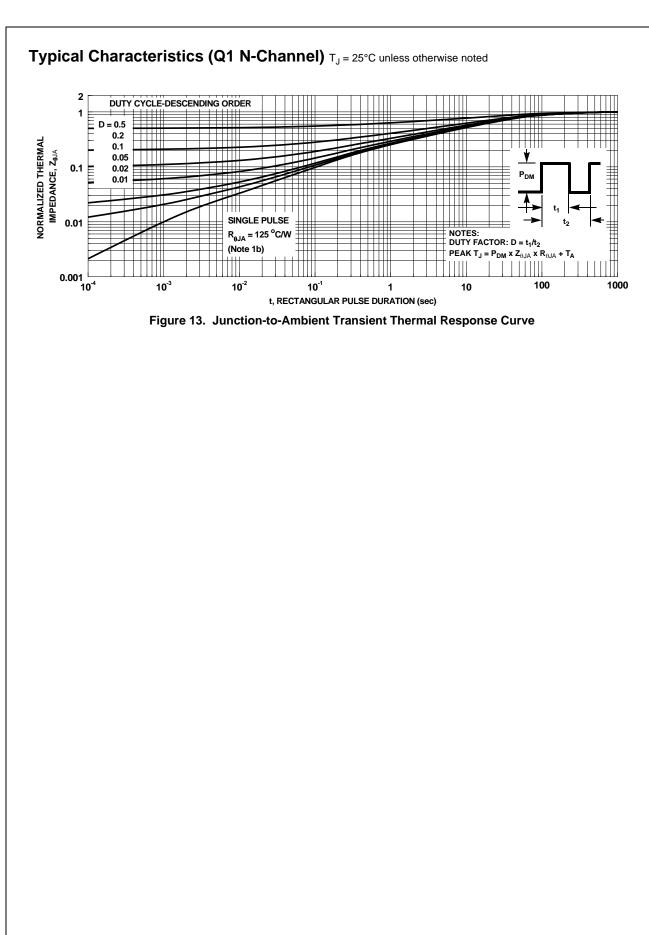


FDMS3626S PowerTrench<sup>®</sup> Power Stage

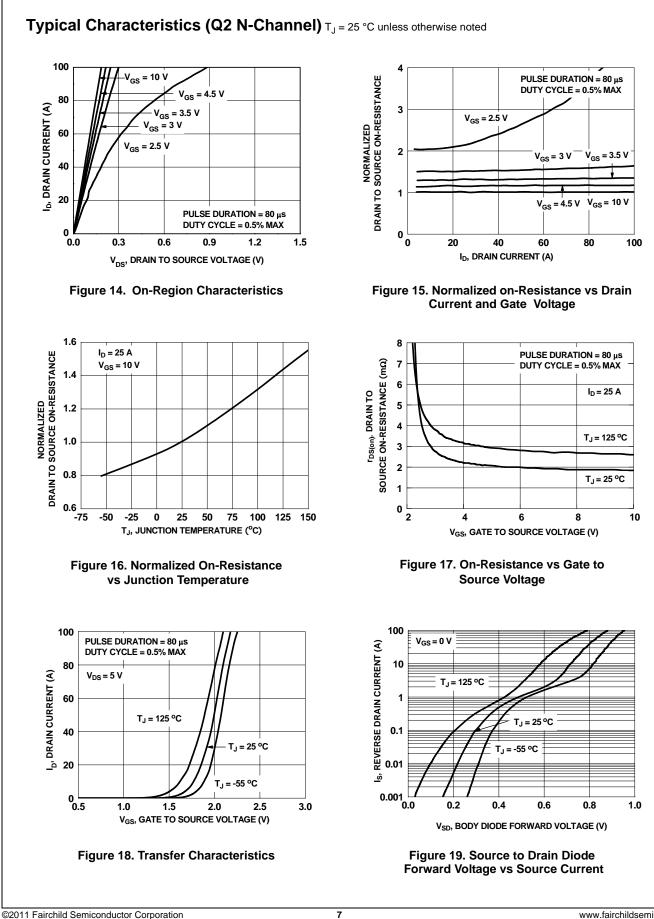


©2011 Fairchild Semiconductor Corporation FDMS3626S Rev.C2





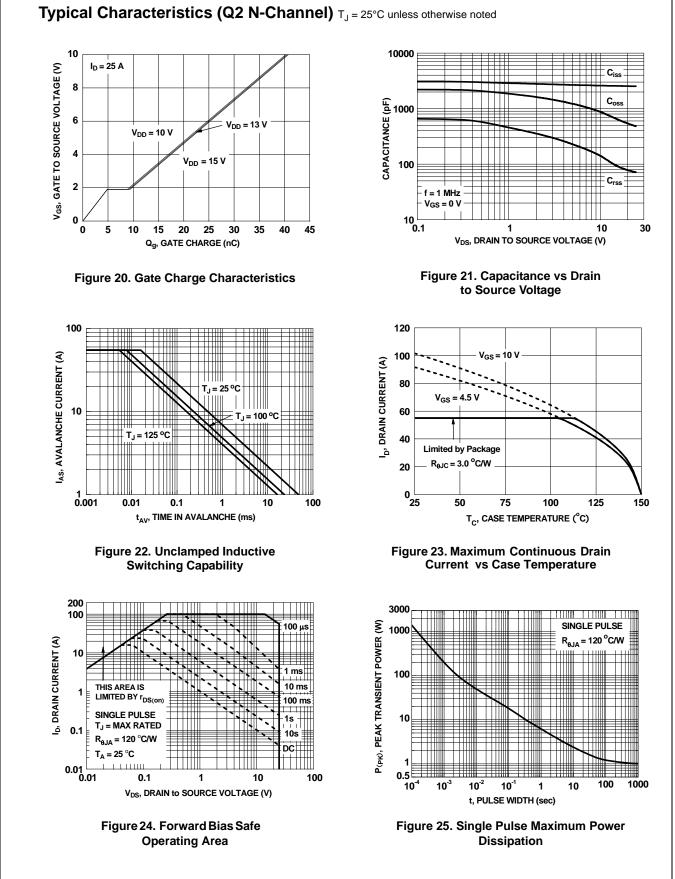
©2011 Fairchild Semiconductor Corporation FDMS3626S Rev.C2



Downloaded from Elcodis.com electronic components distributor

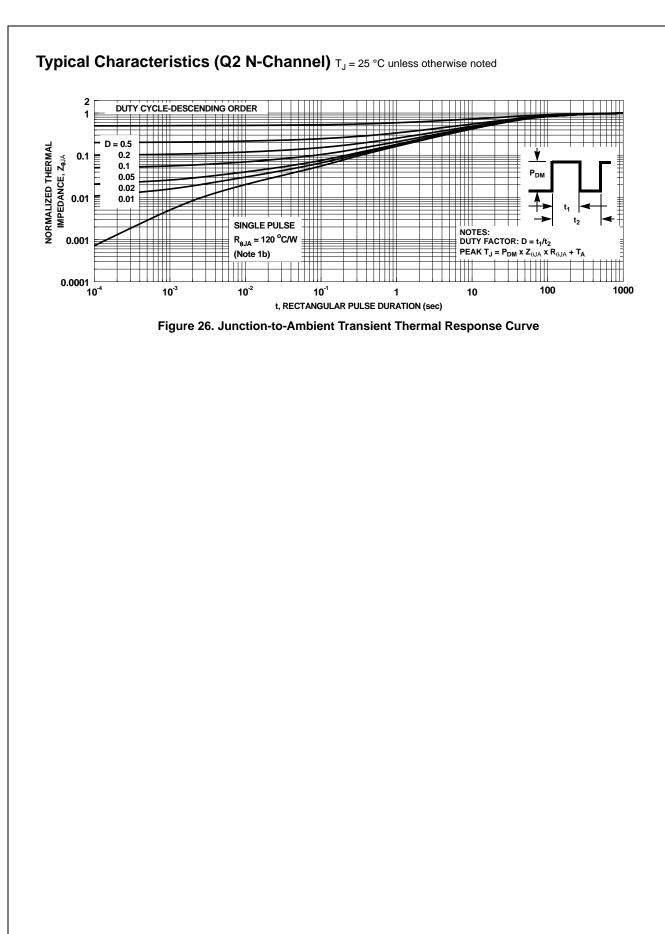
FDMS3626S Rev.C2





©2011 Fairchild Semiconductor Corporation FDMS3626S Rev.C2

FDMS3626S PowerTrench<sup>®</sup> Power Stage



©2011 Fairchild Semiconductor Corporation FDMS3626S Rev.C2

# Typical Characteristics (continued)

#### SyncFET Schottky body diode Characteristics

Fairchild's SyncFET process embeds a Schottky diode in parallel with PowerTrench MOSFET. This diode exhibits similar characteristics to a discrete external Schottky diode in parallel with a MOSFET. Figure 27 shows the reverse recovery characteristic of the FDMS3626S.

Schottky barrier diodes exhibit significant leakage at high temperature and high reverse voltage. This will increase the power in the device.

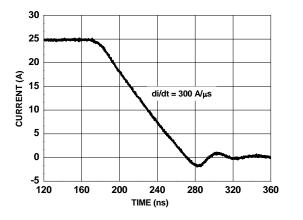
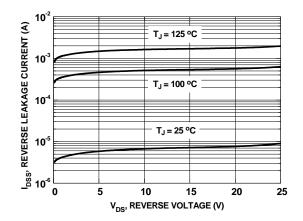
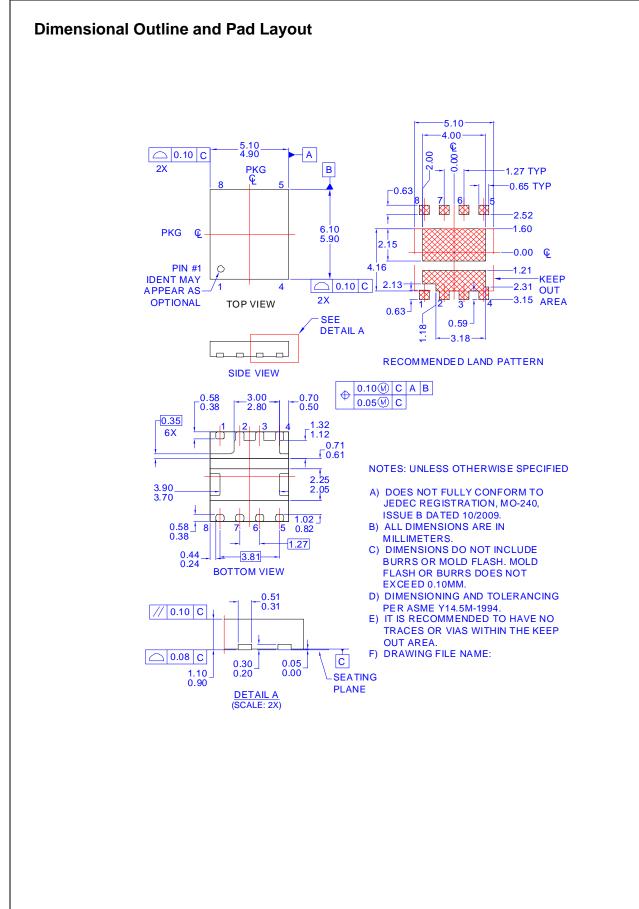


Figure 27. FDMS3626S SyncFET body diode reverse recovery characteristic



# Figure 28. SyncFET body diode reverse leakage versus drain-source voltage





©2011 Fairchild Semiconductor Corporation FDMS3626S Rev.C2



SEMICONDUCTOR

#### TRADEMARKS

The following includes registered and unregistered trademarks and service marks, owned by Fairchild Semiconductor and/or its global subsidiaries, and is not intended to be an exhaustive list of all such trademarks.

2Cool™ AccuPower™ Auto-SPM™ AX-CAP™\* BitSiC<sup>®</sup> Build it Now™ CorePLUS™ CorePOWER™ CROSSVOLT™ CTL™ Current Transfer Logic™ DEUXPEED<sup>®</sup> Dual Cool™ EcoSPARK<sup>®</sup> EfficentMax™ ESBC™

Fairchild Semiconductor®

FACT Quiet Series<sup>™</sup> FACT<sup>®</sup>

FRFET® Global Power Resource<sup>SM</sup> Green FPS™ Green FPS™ e-Series™ G*max*™ GTO™ IntelliMAX™ ISOPLANAR™ Marking Small Speakers Sound Louder and Better™ MegaBuck<sup>™</sup> MICROCOUPLER<sup>™</sup> MicroFET™ MicroPak™ MicroPak2™ MillerDrive™ MotionMax™ Motion-SPM™ mWSaver™ OptoHiT™ **OPTOLOGIC® OPTOPLANAR<sup>®</sup>** 

FPS™

F-PFS™

R PowerTrench<sup>®</sup> PowerXS™ Programmable Active Droop™ OFFT QS™ Quiet Series™ RapidConfigure™ тм Saving our world, 1mW/W/kW at a time™ SignalWise™ SmartMax™ SMART START™ Solutions for Your Success™ SPM® STEALTH™ SuperFET® SuperSOT™-3 SuperSOT™-6 SuperSOT™-8 SupreMOS® SyncFET™ Sync-Lock™ GENERAL ®\*

 tranchise TinyBoost™ TinyBuck™ TinyCalc™ TinyLogic® TINYOPTO™ TinyPower™ TinyPWM™ TinyWire™ TranSiC<sup>®</sup> TriFault Detect™ TRUECURRENT®\* uSerDes™

The Power Franchise<sup>®</sup>

wer

p

FDMS3626S PowerTrench<sup>®</sup> Power Stage



VoltagePlus™ XS™

\*Trademarks of System General Corporation, used under license by Fairchild Semiconductor.

#### DISCLAIMER

₣

Fairchild®

FAST®

FastvCore™

FETBench™

FlashWriter<sup>®</sup> \*

FAIRCHILD SEMICONDUCTOR RESERVES THE RIGHT TO MAKE CHANGES WITHOUT FURTHER NOTICE TO ANY PRODUCTS HEREIN TO IMPROVE RELIABILITY, FUNCTION, OR DESIGN. FAIRCHILD DOES NOT ASSUME ANY LIABILITY ARISING OUT OF THE APPLICATION OR USE OF ANY PRODUCT OR CIRCUIT DESCRIBED HEREIN; NEITHER DOES IT CONVEY ANY LICENSE UNDER ITS PATENT RIGHTS, NOR THE RIGHTS OF OTHERS. THESE SPECIFICATIONS DO NOT EXPAND THE TERMS OF FAIRCHILD'S WORLDWIDE TERMS AND CONDITIONS, SPECIFICALLY THE WARRANTY THEREIN, WHICH COVERS THESE PRODUCTS.

LIFE SUPPORT POLICY FAIRCHILD'S PRODUCTS ARE NOT AUTHORIZED FOR USE AS CRITICAL COMPONENTS IN LIFE SUPPORT DEVICES OR SYSTEMS WITHOUT THE EXPRESS WRITTEN APPROVAL OF FAIRCHILD SEMICONDUCTOR CORPORATION.

As used here in:

- Life support devices or systems are devices or systems which, (a) are 1. intended for surgical implant into the body or (b) support or sustain life. and (c) whose failure to perform when properly used in accordance with instructions for use provided in the labeling, can be reasonably expected to result in a significant injury of the user.
- A critical component in any component of a life support, device, or 2. system whose failure to perform can be reasonably expected to cause the failure of the life support device or system, or to affect its safety or effectiveness.

#### ANTI-COUNTERFEITING POLICY

Fairchild Semiconductor Corporation's Anti-Counterfeiting Policy. Fairchild's Anti-Counterfeiting Policy is also stated on our external website, www.Fairchildsemi.com, under Sales Support.

Counterfeiting of semiconductor parts is a growing problem in the industry. All manufactures of semiconductor products are experiencing counterfeiting of their parts. Customers who inadvertently purchase counterfeit parts experience many problems such as loss of brand reputation, substandard performance, failed application, and increased cost of production and manufacturing delays. Fairchild is taking strong measures to protect ourselves and our customers from the proliferation of counterfeit parts. Fairchild strongly encourages customers to purchase Fairchild parts either directly from Fairchild or from Authorized Fairchild Distributors who are listed by country on our web page cited above. Products customers buy either from Fairchild directly or from Authorized Fairchild Distributors are genuine parts, have full traceability, meet Fairchild's quality standards for handing and storage and provide access to Fairchild's full range of up-to-date technical and product information. Fairchild and our Authorized Distributors will stand behind all warranties and will appropriately address and warranty issues that may arise. Fairchild will not provide any warranty coverage or other assistance for parts bought from Unauthorized Sources. Fairchild is committed to combat this global problem and encourage our customers to do their part in stopping this practice by buying direct or from authorized distributors.

#### PRODUCT STATUS DEFINITIONS **Definition of Terms**

Datasheet Identification	Product Status	Definition
Advance Information	Formative / In Design	Datasheet contains the design specifications for product development. Specifications may change in any manner without notice.
Preliminary	First Production	Datasheet contains preliminary data; supplementary data will be published at a later date. Fairchild Semiconductor reserves the right to make changes at any time without notice to improve design.
No Identification Needed	Full Production	Datasheet contains final specifications. Fairchild Semiconductor reserves the right to make changes at any time without notice to improve the design.
Obsolete	Not In Production	Datasheet contains specifications on a product that is discontinued by Fairchild Semiconductor. The datasheet is for reference information only.

Downloaded from Elcodis.com electronic components distributor